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APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.
10/729,005	12/08/2003	Toshiyasu Shirasuna	03500.015546.1	9109
5514	7590 08/31/2006	EXAMINER		
	CK CELLA HARPER	CROWELL, ANNA M		
30 ROCKEFE NEW YORK.	LLER PLAZA NY 10112		ART UNIT	PAPER NUMBER
,			1763	

DATE MAILED: 08/31/2006

Please find below and/or attached an Office communication concerning this application or proceeding.

	Application No.	Applicant(s)			
	10/729,005	SHIRASUNA ET AL.			
Office Action Summary	Examiner	Art Unit			
	Michelle Crowell	1763			
The MAILING DATE of this communication ap Period for Reply	pears on the cover sheet with the c	orrespondence address			
A SHORTENED STATUTORY PERIOD FOR REPL WHICHEVER IS LONGER, FROM THE MAILING D  - Extensions of time may be available under the provisions of 37 CFR 1. after SIX (6) MONTHS from the mailing date of this communication.  - If NO period for reply is specified above, the maximum statutory period  - Failure to reply within the set or extended period for reply will, by statut Any reply received by the Office later than three months after the mailin earned patent term adjustment. See 37 CFR 1.704(b).	DATE OF THIS COMMUNICATION 136(a). In no event, however, may a reply be time will apply and will expire SIX (6) MONTHS from e, cause the application to become ABANDONE	N. nely filed the mailing date of this communication. D (35 U.S.C. § 133).			
Status					
<ol> <li>Responsive to communication(s) filed on <u>02 August 2006</u>.</li> <li>This action is <b>FINAL</b>. 2b) ☐ This action is non-final.</li> <li>Since this application is in condition for allowance except for formal matters, prosecution as to the merits is closed in accordance with the practice under <i>Ex parte Quayle</i>, 1935 C.D. 11, 453 O.G. 213.</li> </ol>					
Disposition of Claims					
<ul> <li>4) ☐ Claim(s) 12 and 13 is/are pending in the application.</li> <li>4a) Of the above claim(s) is/are withdrawn from consideration.</li> <li>5) ☐ Claim(s) is/are allowed.</li> <li>6) ☐ Claim(s) 12 and 13 is/are rejected.</li> <li>7) ☐ Claim(s) is/are objected to.</li> <li>8) ☐ Claim(s) are subject to restriction and/or election requirement.</li> </ul>					
Application Papers					
9) The specification is objected to by the Examine 10) The drawing(s) filed on is/are: a) accomposed and applicant may not request that any objection to the Replacement drawing sheet(s) including the correct to be a composed and accomposed ac	cepted or b) objected to by the lead of a drawing(s) be held in abeyance. See ction is required if the drawing(s) is object.	e 37 CFR 1.85(a). lected to. See 37 CFR 1.121(d).			
Priority under 35 U.S.C. § 119					
<ul> <li>12) Acknowledgment is made of a claim for foreign priority under 35 U.S.C. § 119(a)-(d) or (f).</li> <li>a) All b) Some * c) None of:</li> <li>1. Certified copies of the priority documents have been received.</li> <li>2. Certified copies of the priority documents have been received in Application No. 09/899188.</li> <li>3. Copies of the certified copies of the priority documents have been received in this National Stage application from the International Bureau (PCT Rule 17.2(a)).</li> <li>* See the attached detailed Office action for a list of the certified copies not received.</li> </ul>					
Attachment(s)  1) D Notice of References Cited (PTO-892)	4) [] Into-tau Sum	(PTO.413)			
<ol> <li>Notice of References Cited (PTO-892)</li> <li>Notice of Draftsperson's Patent Drawing Review (PTO-948)</li> <li>Information Disclosure Statement(s) (PTO-1449 or PTO/SB/08 Paper No(s)/Mail Date</li> </ol>	4) Interview Summary Paper No(s)/Mail Da  5) Notice of Informal P  6) Other:				

#### **DETAILED ACTION**

### Status of Claims

Claims 12-13 are pending in the application. Claims 12-13 are rejected.

#### Continued Examination Under 37 CFR 1.114

A request for continued examination under 37 CFR 1.114, including the fee set forth in 37 CFR 1.17(e), was filed in this application after final rejection. Since this application is eligible for continued examination under 37 CFR 1.114, and the fee set forth in 37 CFR 1.17(e) has been timely paid, the finality of the previous Office action has been withdrawn pursuant to 37 CFR 1.114. Applicant's submission filed on August 2, 2006 has been entered.

## Claim Rejections - 35 USC § 103

- 1. The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:
  - (a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negatived by the manner in which the invention was made.
- 2. This application currently names joint inventors. In considering patentability of the claims under 35 U.S.C. 103(a), the examiner presumes that the subject matter of the various claims was commonly owned at the time any inventions covered therein were made absent any evidence to the contrary. Applicant is advised of the obligation under 37 CFR 1.56 to point out the inventor and invention dates of each claim that was not commonly owned at the time a later

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invention was made in order for the examiner to consider the applicability of 35 U.S.C. 103(c) and potential 35 U.S.C. 102(e), (f) or (g) prior art under 35 U.S.C. 103(a).

3. Claims 12 and 13 are rejected under 35 U.S.C. 103(a) as being unpatentable over Okamura et al. (Japanese Patent Publication 11-319546) in view of Turlot et al. (U.S. 5,515,986).

Referring to Drawing 1, the abstract, and paragraph [0007], Okamura discloses a plasma treatment apparatus comprising a plurality of movable reactors 1100 each an evacuatable inside where at least one treatment substrate 1107 is set in; a high frequency power means 1111 for supplying high-frequency power into each movable reactor having been inside-evacuated, to cause glow discharge to take place in the movable reactor the high-frequency power supply means having a connecting portion for connecting with one of the movable reactors; an impedance regulation means 1110 provided on the side of a movable reactor in order to regulate the impedances of each reactor; and a moving means 1104 for moving the reactors, wherein each of the movable reactors and the high-frequency power supply means are provided separably and wherein one impedance regulation means is provided between a connecting portion of the high-frequency power supply means on the exterior of the moveable reactor and an electrode on the interior of the moveable reactor.

Okamura et al. fail to teach an impedance regulation means provided on the side of each reactor that allows for different impedance for each reactor.

Referring to Figures 2a-2d, 5c, column 3, line 60 –column 4, line 20, and column 6, line 62-column 7, line 21, Turlot et al. teaches a plasma treatment apparatus having an impedance regulation means (inductors in Fig. 5c. Additionally, each inductor is capable of providing a different impedance which results in different chamber conditions (Note. Different chamber

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conditions results in different process treatments) provided on the exterior of each reactor 20. By using an impedance regulation means for each reactor, the process conditions may be adjusted for each reactor (col. 7, lines 2-9). Thus, it would have been obvious to one of ordinary skill in the art at the time of the invention to provide each reactor of Okamura et al. with an impedance regulation means as taught by Turlot et al. in order to adjust the process conditions for each reactor.

With respect to the limitation of each reactor conducting a different treatment, the apparatus of Okamura et al. in view of Turlot et al. (specifically Turlot et al.) teaches that inductors allow different chamber conditions or treatments to occur. Furthermore, since the claims are directed to an apparatus, this limitation is considered an intended use limitation and a recitation of the intended use of the claimed invention must result in a structural difference between the claimed invention and the prior art in order to patentably distinguish the claimed invention from the prior art. If the prior art structure is capable of performing the intended use, then it meets the claim. Thus, as stated above, the apparatus of Okamura et al. in view of Turlot et al. is capable of performing the claimed different treatment for each reactor.

With respect to claim 13, Okamura et al. discloses that the substrate is an electrophotographic photosensitive member (abstract and par.[0007]). Additionally, it should be noted that the type of substrate (i.e. electrophotographic photosensitive member) used in apparatus claims is not given patentable weight (In re Young, 75 F.2d 996, 25 USPQ 69 (CCPA 1935) (as restated in In re Otto, 312 F.2d 937, 136 USPQ 458, 459 (CCPA 1963))).

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## Response to Arguments

7. Applicant's arguments filed August 2, 2006 have been fully considered but they are not persuasive.

Applicant has argued that Turlot fails to teach that only one reactor is connected to one power supply means as shown in Figure 8; however, the **elected species is Figure 5**, and an according to page 19, lines 21-24 of the specification, only one high-frequency power supply means is used for many reactors. Furthermore, claim 12 fails to require that only one reactor is connected to one power supply, it simply states that "a high frequency power supply means has a connecting portion for connecting with one of the movable reactors. The same connecting portion can connect with different reactors at different times. Thus, the apparatus of Okamura et al. in view of Turlot et al. satisfies the claimed requirement.

Applicant has argued that the applicant's invention includes only a single impedance regulation means for each reactor and that Turlot teaches an impedance regulation means for each electrode; however, as seen in Figure 5(c) and column 7, lines 7-9, one single impedance regulation means is assigned to each reactor (not each electrode). In addition, the structure of the applicant's invention (Figure 5) includes one power source 111, one matching device 112', and an impedance regulation means 101U, 151U, 161U provided on each reactor 104, 154, 164. Similarly, the apparatus of Okamura et al. in view Turlot et al. (specifically Turlot et al. Fig. 5c, col. 7, lines1-9) shows a structure that includes one power source (not shown), one matching device, and an impedance regulation means (inductors) provided on each reactor 1. Thus, the apparatus of Okamura et al. in view of Turlot et al. satisfies the claimed requirement.

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Any inquiry concerning this communication or earlier communications from the examiner should be directed to Michelle Crowell whose telephone number is (571) 272-1432. The examiner can normally be reached on M-F (9:30 -6:00).

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Parviz Hassanzadeh can be reached on (571) 272-1435. The fax phone number for the organization where this application or proceeding is assigned is 571-273-8300.

Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see http://pair-direct.uspto.gov. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free).

Michelle Crowell
Patent Examiner
Art Unit 1763

Parviz Hassanzadeh Supervisory Patent Examiner Art Unit 1763